

**Search Notes**

Application/Control No.

10/783,670

Examiner

Benjamin H. Layno

Applicant(s)/Patent under  
Reexamination

KO, SHENLI

Art Unit

3711

**SEARCHED**

Class	Subclass	Date	Examiner
273	292, 274, 309	6/2/2005	BHL
463	12, 13		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	6/2/2005	BHL